Electronic Devices and Circuits

BEG230EC

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Semester: III

Teaching Schedule Hours/Week			Examination Scheme				
Theory	Tutorial	Practical	Internal Ass	sessment	Final		Total
3	1	2	Theory	Practical	Theory	Practical	125
			20	25	80	2 2	

Course Objective: To introduce students about the working principles and applications of semi-conductor devices such as diodes, transistors, and FETs.

Course Contents:

1. Semiconductor diode

[8 hrs]

- 1.1 Review of p-n junction diode
- 1.2 Analysis of diode circuits
- 1.3 Applications of p-n junction diode
 - 1.3.1 Clipping and Clamping circuits
 - 1.3.2 Rectification (half wave, full wave and bridge rectifier)
- 1.4 Types of diode (Schottky, varactor, tunnel, zener)
- 1.5 Zener diode as a voltage regulator

2. Bipolar Junction Transistor

[18hrs]

- 2.1 Construction of a BJT
- 2.2 Ebers-Molls Equation
- 2.3 Basic Transistor Equation
- 2.4 CB, CC, CE Configurations
- 2.5 Load line analysis
- 2.6 Transistor as an amplifier
- 2.7 Types of biasing
- 2.8 Biasing stabilization and thermal runaway
- 2.9 Small signal analysis (h-parameter and re' model)
- 2.10 High Frequency t-model

3. Applications of BJT

[11hrs]

- 3.1 Power amplifiers (Class A, B, C, AB and efficiency calculation)
- 3.2 BJT as a switch
- 3.3 Cascaded amplifier (Single stage and multistage)
- 3.4 Untuned amplifier
 - 3.4.1 Frequency and phase response of RC coupled amplifier
- 3.5 Differential Amplifiers

4. Field Effect Transistors

[8hrs]

- 4.1 Junction field effect transistor (JFET)
 - 4.1.1 Construction and characteristics
 - 4.1.2 Biasing of JFET
 - 4.1.3 Small signal analysis of JFET
 - 4.1.4 UJT as an oscillator

4.2 MOSFET

- 4.2.1 Construction, characteristics and types
- 4.2.2 Biasing of MOSFET
- 4.2.3 NMOS (Depletion and enhancement type)
- 4.2.4 Introduction to CMOS



Practicals (In Trainer kits, Multisim and P-Spice):

- Measurement of characteristics of diode, zener diode
- 2. Rectifier circuits
- 3. Measurement of input and output characteristics of CE configurations
- Single stage BJT amplifier
- Measurement of input and output characteristics of JFET
- 6. Measurement of input and output characteristics of MOSFET

Reference Books:

- 1. A. S. Sedra & K. C. Smith, "Microelectronic Circuits", 6th Edition, Oxford University Press
- Theodorre S. Bogart, "Electronic Devices and Circuits"
- 3. Millman & Halkias, "Electronic Devices and Circuits", McGraw Hill
- 4. Robert Boylestad, "Electronic Devices and Circuits"
- 5. M. N. Horenstein, "Microelectronic Circuits and Devices", Second Edition, Prentice Hall

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